

STN	Nepremenné kondenzátory na použitie v elektronických zariadeniach. Časť 1: Všeobecná špecifikácia.	STN EN 60384-1 35 8291
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Fixed capacitors for use in electronic equipment - Part 1: Generic specification

Táto norma obsahuje anglickú verziu európskej normy.
This standard includes the English version of the European Standard.

Táto norma bola oznámená vo Vestníku ÚNMS SR č. 03/17

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EUROPEAN STANDARD
NORME EUROPÉENNE
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EN 60384-1

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English Version

**Fixed capacitors for use in electronic equipment - Part 1:
Generic specification
(IEC 60384-1:2016)**

Condensateurs fixes utilisés dans les équipements
électroniques - Partie 1: Spécification générique
(IEC 60384-1:2016)

Festkondensatoren zur Verwendung in Geräten der
Elektronik - Teil 1: Fachgrundspezifikation
(IEC 60384-1:2016)

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Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

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European foreword

The text of document 40/2420/FDIS, future edition 5 of IEC 60384-1, prepared by IEC/TC 40 "Capacitors and resistors for electronic equipment" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 60384-1:2016.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2017-03-30
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2019-09-30

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In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60384-2	NOTE	Harmonized as EN 60384-2.
IEC 60384-3	NOTE	Harmonized as EN 60384-3.
IEC 60384-3-1	NOTE	Harmonized as EN 60384-3-1.
IEC 60384-26	NOTE	Harmonized as EN 60384-26.
IEC 60469:2013	NOTE	Harmonized as EN 60469:2013.
ISO 9000	NOTE	Harmonized as EN ISO 9000.

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60027	series	Letter symbols to be used in electrical technology	EN 60027	series
IEC 60050	series	International Electrotechnical Vocabulary -		series
IEC 60062	-	Marking codes for resistors and capacitors	EN 60062	-
IEC 60063	-	Preferred number series for resistors and capacitors	EN 60063	-
IEC 60068-1	2013	Environmental testing -- Part 1: General and guidance	EN 60068-1	2014
IEC 60068-2-1	2007	Environmental testing -- Part 2-1: Tests - Test A: Cold	EN 60068-2-1	2007
IEC 60068-2-2	2007	Environmental testing -- Part 2-2: Tests - Test B: Dry heat	EN 60068-2-2	2007
IEC 60068-2-6	2007	Environmental testing -- Part 2-6: Tests - Test Fc: Vibration (sinusoidal)	EN 60068-2-6	2008
IEC 60068-2-13	1983	Basic environmental testing procedures - Part 2-13: Tests - Test M: Low air pressure	EN 60068-2-13	1999
IEC 60068-2-14	2009	Environmental testing -- Part 2-14: Tests - Test N: Change of temperature	EN 60068-2-14	2009
IEC 60068-2-17	1994	Basic environmental testing procedures - Part 2-17: Tests - Test Q: Sealing	EN 60068-2-17	1994
IEC 60068-2-20	2008	Environmental testing -- Part 2-20: Tests - Test T: Test methods for solderability and resistance to soldering heat of devices with leads	EN 60068-2-20	2008
IEC 60068-2-21	2006	Environmental testing -- Part 2-21: Tests - Test U: Robustness of terminations and integral mounting devices	EN 60068-2-21	2006
IEC 60068-2-27	2008	Environmental testing -- Part 2-27: Tests - Test Ea and guidance: Shock	EN 60068-2-27	2009
IEC 60068-2-30	2005	Environmental testing -- Part 2-30: Tests - Test Db: Damp heat, cyclic (12 h + 12 h cycle)	EN 60068-2-30	2005
IEC 60068-2-45 AMD 1	1993	Basic environmental testing procedures; - part_2: tests; test_XA and guidance: immersion in cleaning solvents; amendment_1		-
IEC 60068-2-45	1980	Basic environmental testing procedures - Part 2-45: Tests - Test XA and guidance: Immersion in cleaning solvents	EN 60068-2-45	1992

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IEC 60068-2-54	2006	Environmental testing - Part 2-54: Tests -EN 60068-2-54	2006
		Test Ta: Solderability testing of electronic components by the wetting balance method	
IEC 60068-2-58	2015	Environmental testing - Part 2-58: Tests -EN 60068-2-58	2015
		Test Td: Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)	
IEC 60068-2-67	1995	Environmental testing -- Part 2: Tests -EN 60068-2-67	1996
		Test Cy: Damp heat, steady state, accelerated test primarily intended for components	
IEC 60068-2-69	2007	Environmental testing - Part 2: Tests - TestEN 60068-2-69	2007
		Te: Solderability testing of electronic components for surface mounting devices (SMD) by the wetting balance method	
IEC 60068-2-78	2012	Environmental testing -- Part 2-78: Tests -EN 60068-2-78	2013
		Test Cab: Damp heat, steady state	
IEC 60068-2-82	2007	Environmental testing -- Part 2-82: Tests -EN 60068-2-82	2007
		Test XW1: Whisker test methods for electronic and electric components	
IEC 60294	-	Measurement of the dimensions of aEN 60294	-
		cylindrical component with axial terminations	
IEC 60617	-	Standard data element types with-associated classification scheme for electric components -- Part 4: IEC reference collection for standard data element types and component classes	-
IEC 60695-11-5	2004	Fire hazard testing -- Part 11-5: TestEN 60695-11-5	2005
		flames - Needle-flame test method - Apparatus, confirmatory test arrangement and guidance	
IEC 60717	-	Method for the determination of the spaceEN 60717	-
		required by capacitors and resistors with unidirectional terminations	
IEC 61193-2	-	Quality assessment systems -- Part 2:EN 61193-2	-
		Selection and use of sampling plans for inspection of electronic components and packages	
IEC 61249-2-7	2002	Materials for printed boards and otherEN 61249-2-7	2002
		interconnecting structures -- Part 2-7: Reinforced base materials, clad and unclad - Epoxide woven E-glass laminated sheet of defined flammability (vertical burning test), copper-clad	
-	-	+ corrigendum Sep. 2005	
ISO 3	-	Preferred numbers; Series of preferred-numbers	-
ISO 80000-1	-	Quantities and units -- Part 1: General EN ISO 80000-1	-



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**Fixed capacitors for use in electronic equipment –
Part 1: Generic specification**

**Condensateurs fixes utilisés dans les équipements électroniques –
Partie 1: Spécification générique**



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –**Part 1: Generic specification****FOREWORD**

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International Standard IEC 60384-1 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment

This fifth edition cancels and replaces the fourth edition published in 2008 and constitutes a technical revision, including minor revisions related to tables, figures and references.

This edition contains the following significant technical changes with respect to the previous edition:

- INTRODUCTION added;
- 4.41 Whisker growth test added;
- Annex Q completely restructured.

The text of this standard is based on the following documents:

FDIS	Report on voting
40/2420/FDIS	40/2444/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

A list of all the parts of the IEC 60384 series, under the general title *Fixed capacitors for use in electronic equipment*, can be found on the IEC website.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

INTRODUCTION

The specification system for fixed capacitors for use in electronic equipment is structured in a hierarchical system consisting of the following specification types.

Generic specification

The generic specification covers all subjects mainly common to the family of fixed capacitors for use in electronic equipment, such as terminology, methods of measurement and tests. Where the individual subjects require the prescription conditions or parameters specific to the particular subfamily or type of fixed capacitor, such prescriptions are required to be given by one of the subordinate specifications.

For the scope of fixed capacitors, the numeric reference to the generic specification is IEC 60384-1.

Sectional specification

Sectional specifications cover all subjects additional to those given in the generic specification, which are specific to a defined sub-group of fixed capacitors. These subjects normally are preferred values for dimensions and characteristics, additional test methods and relevant prescriptions for test methods given in the generic specification, prescriptions for sampling and for the preparation of specimen, recommended test severities and preferred acceptance criteria. The sectional specification also outlines the structure and scope of the test schedules which are to be applied in all subordinate detail specifications.

For the scope of fixed capacitors, the numeric references to the sectional specifications reach from IEC 60384-2 for polyester film capacitors to currently IEC 60384-26 for aluminium electrolytic capacitors with conductive polymer solid electrolyte. The variety of sectional specifications may be adapted to the portfolio of different technologies of fixed capacitors.

Detail specification

Detail specifications give directly, or by making reference to other specifications, all information necessary to completely describe a given type and range of fixed capacitors, including prescriptions of all values for dimensions and characteristics. They also give all information required for the quality assessment of the covered type and range of fixed capacitors within a suitable quality assessment system, including prescriptions for all applied test severities and acceptance criteria, and the completed test schedules.

Detail specifications can be either specifications within the IEC system, another specification system linked to IEC, or specified by the manufacturer or user. For the scope of fixed capacitors, the numeric references to detail specifications are for example IEC 60384-3-101, if related to the sectional specification IEC 60384-3 and to the ancillary blank detail specification IEC 60384-3-1.

Blank detail specification

The hierarchical system of specifications is supplemented by one or more blank detail specifications to a sectional specification, which are used to ensure a uniform presentation of detail specifications. The blank detail specifications provide the specification writer with a template on the layout to be adopted and on the information to be given and with guidance for the preparation of detail specifications in line with the requirements of the superior generic or sectional specifications. Blank detail specifications are not considered as relevant specifications since they do not themselves describe any particular component.

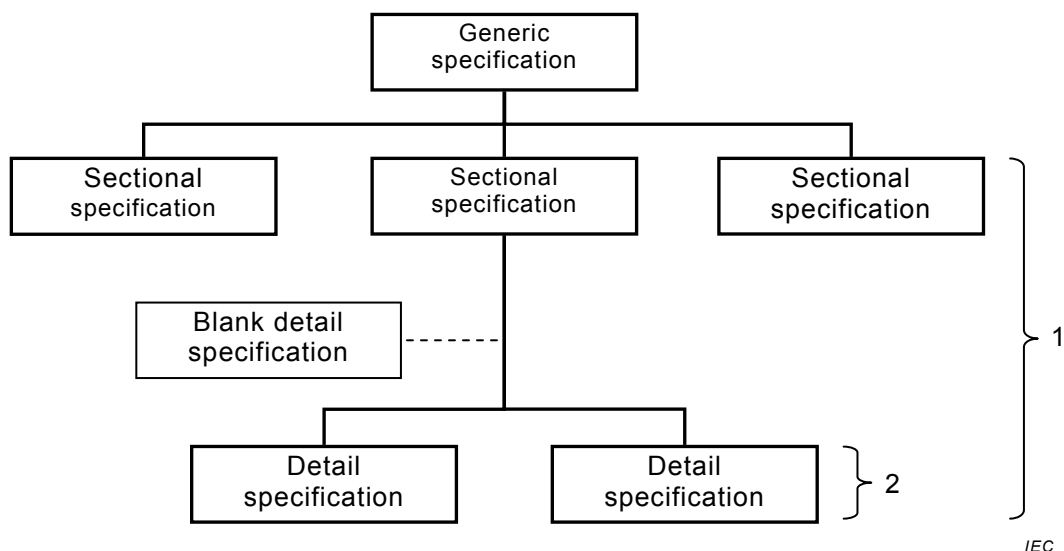
The presence of an established hierarchical specification system with blank detail specifications permits the preparation of detail specifications even outside of the relevant IEC technical committee.

For the scope of fixed capacitors, the numeric references to blank detail specifications are, for example, IEC 60384-3-1, if related to the sectional specification IEC 60384-3.

Relevant specification

In this system the term “relevant specification” addresses subordinate specifications containing specific requirements, where applicable.

Any generic or sectional specification may use abstract and universal references to subordinate specifications of either hierarchical level by use of the expression “relevant specification”.



Key

- 1 Indicates the range of “*Relevant specifications*” to the superior generic specification, where applicable.
- 2 Indicates the range of “*Relevant specifications*” to the superior sectional specification, where applicable.

FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –

Part 1: Generic specification

1 General

1.1 Scope

This part of IEC 60384 is a generic specification and is applicable to fixed capacitors for use in electronic equipment.

It establishes standard terms, inspection procedures and methods of test for use in sectional and detail specifications of electronic components for quality assessment or any other purpose.

1.2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60027 (all parts), *Letter symbols to be used in electrical technology*

IEC 60050 (all parts), *International Electrotechnical Vocabulary*¹

IEC 60062, *Marking codes for resistors and capacitors*

IEC 60063, *Preferred number series for resistors and capacitors*

IEC 60068-1:2013, *Environmental testing – Part 1: General and guidance*

IEC 60068-2-1:2007, *Environmental testing – Part 2-1: Tests – Tests A: Cold*

IEC 60068-2-2:2007, *Environmental testing – Part 2-2: Tests – Tests B: Dry heat*

IEC 60068-2-6:2007, *Environmental testing – Part 2-6: Tests – Test Fc: Vibration (sinusoidal)*

IEC 60068-2-13:1983, *Environmental testing – Part 2-13: Tests – Test M: Low air pressure*

IEC 60068-2-14:2009, *Environmental testing – Part 2-14: Tests – Test N: Change of temperature*

IEC 60068-2-17:1994, *Environmental testing – Part 2-17: Tests – Test Q: Sealing*

IEC 60068-2-20:2008, *Environmental testing – Part 2-20: Tests – Test T: Test methods for solderability and resistance to soldering heat of devices with leads*

IEC 60068-2-21:2006, *Environmental testing – Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices*

¹ www.electropedia.org

IEC 60068-2-27:2008, *Environmental testing – Part 2-27: Tests – Test Ea and guidance: Shock*

IEC 60068-2-30:2005, *Environmental testing – Part 2-30: Tests – Test Db: Damp heat, cyclic (12 h + 12 h cycle)*

IEC 60068-2-45:1980, *Environmental testing – Part 2-45: Tests – Test XA and guidance: Immersion in cleaning solvents*
IEC 60068-2-45:1980/AMD1:1993

IEC 60068-2-54:2006, *Environmental testing – Part 2-54: Tests – Test Ta: Solderability testing of electronic components by the wetting balance method*

IEC 60068-2-58:2015, *Environmental testing – Part 2-58: Tests – Test Td: Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)*

IEC 60068-2-67:1995, *Environmental testing – Part 2-67: Tests – Test Cy: Damp heat, steady state, accelerated test primarily intended for components*

IEC 60068-2-69:2007, *Environmental testing – Part 2-69: Tests – Test Te: Solderability testing of electronic components for surface mounting devices (SMD) by the wetting balance method*

IEC 60068-2-78:2012, *Environmental testing – Part 2-78: Tests – Test Cab: Damp heat, steady state*

IEC 60068-2-82:2007, *Environmental testing – Part 2-82: Tests – Test XW1: Whisker test methods for electronic and electric components*

IEC 60294, *Measurement of the dimensions of a cylindrical component with axial terminations*

IEC 60617, *Graphical symbols for diagrams*

IEC 60695-11-5:2004, *Fire hazard testing – Part 11-5: Test flames – Needle-flame test method – Apparatus, confirmatory test arrangement and guidance*

IEC 60717, *Method for the determination of the space required by capacitors and resistors with unidirectional terminations*

IEC 61193-2, *Quality assessment systems – Part 2: Selection and use of sampling plans for inspection of electronic components and packages*

IEC 61249-2-7:2002, *Materials for printed boards and other interconnecting structures – Part 2-7: Reinforced base materials clad and unclad – Epoxide woven E-glass laminated sheet of defined flammability (vertical burning test), copper-clad*

ISO 3, *Preferred numbers – Series of preferred numbers*

ISO 80000-1, *Quantities and units – Part 1: General*

koniec náhľadu – text ďalej pokračuje v platenej verzii STN